1

N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	<b>R<sub>DS(on)</sub> (</b> Ω <b>)</b>	I <sub>D</sub> (A)			
20	0.0068 at $V_{GS}$ = 4.5 V	25			
20	0.0096 at V <sub>GS</sub> = 2.5 V	20			

Bottom View

DFN 2x2

Top View

#### **FEATURES**

- TrenchFET<sup>®</sup> Power MOSFET
- ESD Protected: 4000 V
- Common Drain

#### APPLICATIONS

• 1-2 Cell Battery Protection Circuitry

Limit

20 V Gate-Source Voltage ± 12 V<sub>GS</sub> T<sub>C</sub> = 25 °C 25<sup>a</sup> T<sub>C</sub> = 70 °C 20<sup>a</sup> Continuous Drain Current (T<sub>J</sub> = 150 °C)  $I_D$ T<sub>A</sub> = 25 °C 18<sup>a, b, c</sup> T<sub>A</sub> = 70 °C <u>15.1</u><sup>b, c</sup> А Pulsed Drain Current I<sub>DM</sub> 75 T<sub>C</sub> = 25 °C 12<sup>a</sup> Continuous Source-Drain Diode Current T<sub>A</sub> = 25 °C  $I_S$ 2.9<sup>b, c</sup> T<sub>C</sub> = 25 °C 24.2 T<sub>C</sub> = 70 °C 16.3 Maximum Power Dissipation  $P_D$ W T<sub>A</sub> = 25 °C 3.5<sup>b, c</sup> 2.2<sup>b, c</sup> T<sub>A</sub> = 70 °C Operating Junction and Storage Temperature Range - 55 to 150 T<sub>J</sub>, T<sub>stg</sub> °C Soldering Recommendations (Peak Temperature)<sup>d, e</sup> 260

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	28	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	5.3	6.5	0/11	

Notes: a. Package limited

b. Surface mounted on 1" x 1" FR4 board.

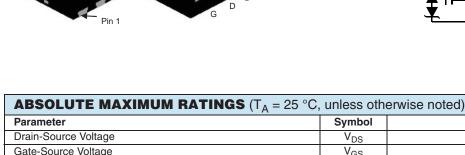
c. t = 5 s.

d. The DFN2X2 is a leadless package. The end of the lead terminal is exposed

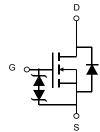
copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 80  $^{\circ}\text{C/W}.$ 



Pin 1





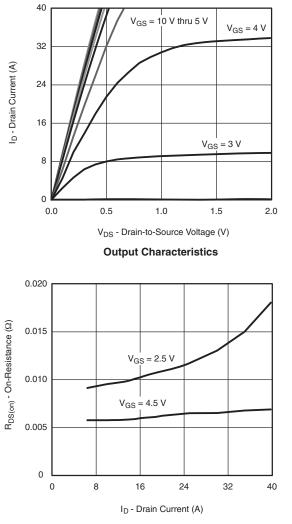
Unit



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		24		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	l <sub>D</sub> = 250 μA		- 5.6		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.5		1.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 12 V$			± 5	μA
		$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}$	25			Α
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7 A		0.0068	0.0075	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 5 A		0.0096	0.0113	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7 A		16		S
Dynamic <sup>b</sup>	1		I	1	I	
Input Capacitance	C <sub>iss</sub>			800		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		200		
Reverse Transfer Capacitance	C <sub>rss</sub>			90		
Total Gate Charge	Qg	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 12 \text{ A}$		12	18	nC
				5.3	9	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 12 \text{ A}$		2		
Gate-Drain Charge	Q <sub>gd</sub>			1.4		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		2.5		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			16	25	ns
Rise Time	t <sub>r</sub>			10	15	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 10 \text{ V}, \text{ R}_{\text{L}} = 1 \Omega$ $\text{I}_{\text{D}} \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{a}} = 1 \Omega$		15	25	
Fall Time	t <sub>f</sub>	1D = 1070, VGEN = 4.00, Vg = 1.32		10	15	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 10 V, R <sub>I</sub> = 1 Ω		8	15	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 10$ V, $H_L = 1.22$ $I_D \simeq 10$ A, $V_{GEN} = 4.5$ V, $R_a = 1 \Omega$		17	30	
Fall Time	t <sub>f</sub>			8	15	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			12	A
Pulse Diode Forward Current	I <sub>SM</sub>				75	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			18	30	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$L = 10.0 \text{ d}/\text{d} = 100.0 \text{ d}/\text{u}_{2}$ T = 05.00		7	15	nC
Reverse Recovery Fall Time	t <sub>a</sub>	· I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		8		
verse Recovery Rise Time t <sub>b</sub>				10		ns

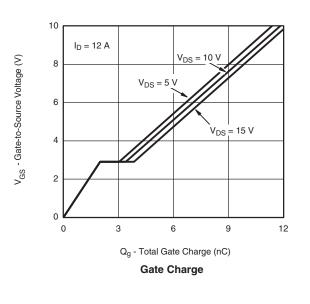
Notes: a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

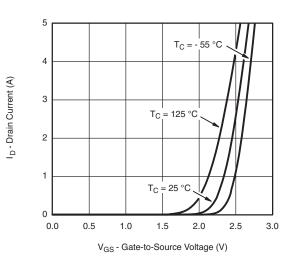
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



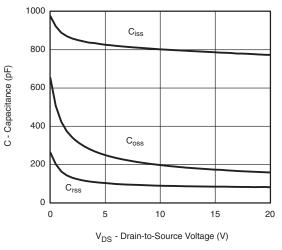
#### TYPICAL CHARACTERISTIC (25 °C, unless otherwise noted)

On-Resistance vs. Drain Current and Gate Voltage

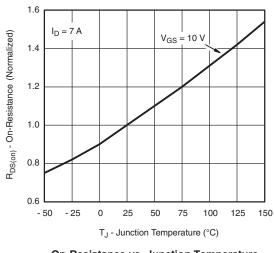




**Transfer Characteristics** 

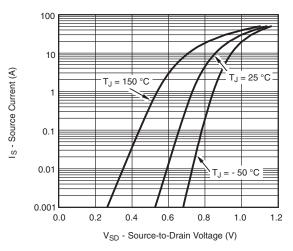


Capacitance

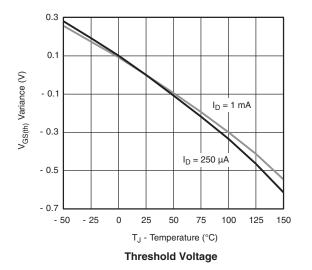


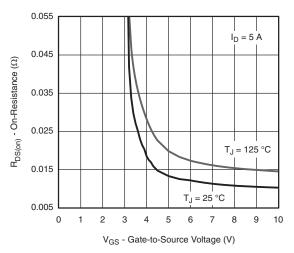
**On-Resistance vs. Junction Temperature** 

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

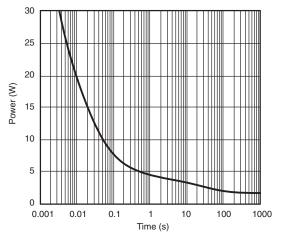


Source-Drain Diode Forward Voltage

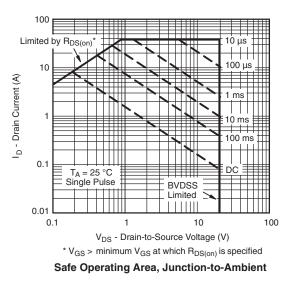


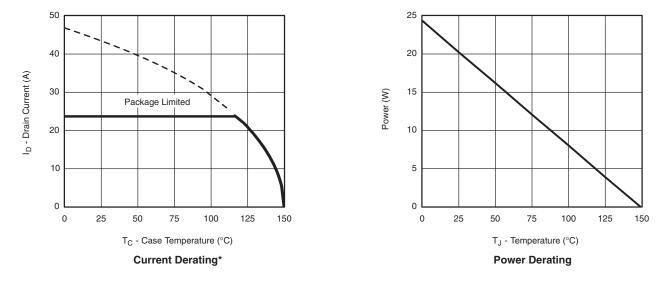


On-Resistance vs. Gate-to-Source Voltage



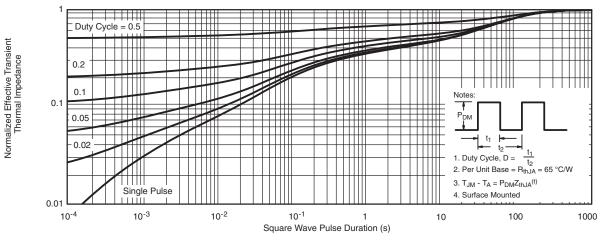
Single Pulse Power (Junction-to-Ambient)





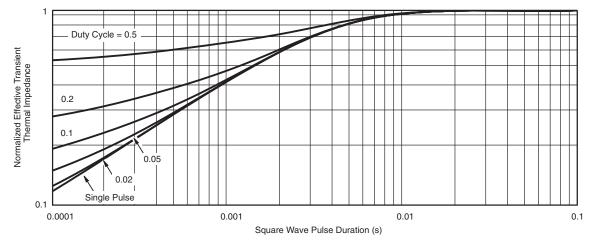
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



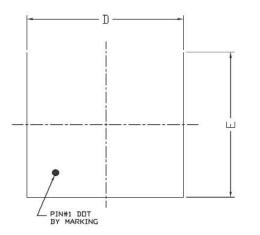
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

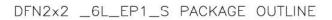


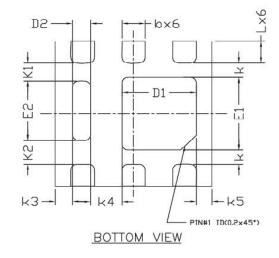


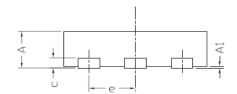
Normalized Thermal Transient Impedance, Junction-to-Case



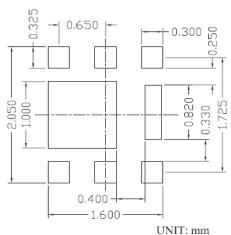








#### RECOMMENDED LAND PATTERN



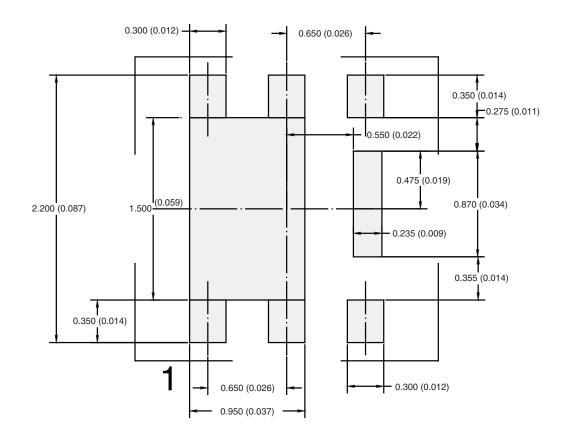
SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
А	0.50	0.55	0.60	0.020	0.022	0.024	
A1	0.00		0.05	0.000		0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
с	0.152 REF			0.006 REF			
D	1.90	2.00	2.10	0.075	0.079	0.083	
D1	0.85	0.95	1.05	0.033	0.037	0.041	
D2	0.13	0.23	0.33	0.005	0.009	0.013	
E	1.90	2.00	2.10	0.075	0.079	0.083	
E1	0.90	1.00	1.10	0.035	0.039	0.043	
E2	0.72	0.82	0.92	0.028	0.032	0.036	
е	0.65 BSC			0.026 BSC			
K	0.20 BSC			0.008 BSC			
K1	0.25 BSC			0.010 BSC			
K2	0.33 BSC			0.013 BSC			
K3	0.22 BSC			0.009 BSC			
K4	0.40 BSC			0.016 BSC			
K5	0.20 BSC			0.008 BSC			
L	0.25	0.30	0.35	0.010	0.012	0.014	

NOTE

1. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



### **RECOMMENDED PAD LAYOUT FOR DFN2X2**



Dimensions in mm/(Inches)



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